

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/791,669	SHIRAISHI ET AL.	
	Examiner	Art Unit	
	John P. Sheehan	1742	

## **Search Notes**



**Application/Control No.**

10/791,669

Examiner

John P. Sheehan

**Applicant(s)/Patent under  
Reexamination**

SHIRAISHI ET AL.

Art Unit

1742

## **INTERFERENCE SEARCHED**

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

## **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**